## Application/Control No. Applicant(s)/Patent Under Reexamination 10/717,617 CHEN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Helen C. Kwok 2856 **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,504,385	01-2003	Hartwell et al.	324/662
	В	US-6,041,653	03-2000	Ichikawa et al.	73/514.32
	С	US-6,230,564	05-2001	Matsunaga et al.	73/514.01
	D	US-6,105,427	08-2000	Stewart et al.	73/514.32
	Е	US-6,082,197	07-2000	Mizuno et al.	73/514.36
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				<del>.</del>	
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*			Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U	:		-				
	٧	:						
	w							
	х							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.